

<b>Notice of References Cited</b>	Application/Control No. 10/054,888	Applicant(s)/Patent Under Reexamination SEILER ET AL.	
	Examiner Hanh V. Tran	Art Unit 3637	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,394,402	05-2002	Coonan et al.	248/123.11
	B	US-6,286,794	09-2001	Harbin, Bradley	248/918
	C	US-6,182,579	02-2001	Chang, Chien-Kuo	108/50.01
	D	US-5,743,503	04-1998	Voeller et al.	248/284.1
	E	US-5,174,223	12-1992	Nagy et al.	108/50.01
	F	US-5,027,989	07-1991	Nevius, David L.	108/6
	G	US-4,938,153	07-1990	Maes, Daniel T.	108/6
	H	US-4,852,500	08-1989	Ryburg et al.	108/50.01
	I	US-4,632,349	12-1986	Anstey, Kenneth D.	248/918
	J	US-4,566,741	01-1986	Eriksson et al.	108/7
	K	US-4,383,486	05-1983	Reineman et al.	108/6
	L	US-1,933,210	10-1933	Curtis	108/50.14
	M	US-1,363,335	12-1920	McFarlane	108/8

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2112279	07-1983	Great Britain	Nilsson	
	O	2592288	07-1987	France	Ortubay	108/7
	P	3321298	12-1984	Germany	Lepper	108/6
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.